Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/634,269	YAO ET AL.	
Examiner	Art Unit	
Mark Blouin	2627	

	SEARCHED				
Class	Subclass	Date	Examiner		
360	245.9	6/17/06	***		
360	244.2	6/13/16	w		
360	264.2	6/13/00	3		
29	603.03	6/17/06	M		
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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